

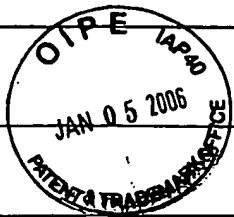
Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. <b>240602US0DIV</b>		SERIAL NO. <b>10/625,570</b> <b>New Application</b>	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT <b>Nozomu TAMOTO, et al.</b>			
				FILING DATE Herewith		GROUP <b>1714</b>	
<b>U.S. PATENT DOCUMENTS</b>							
EXAMINER INITIAL	CLASS	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
<b>SKP</b> ↓	AA	3,736,134	5/29/73	D.W. GOSSELINK, et al.			
	AB	4,820,620	4/11/89	D.J. CAROLLA			
	AC	6,030,733	2/29/00	KAMI, et al.			
	AD	6,136,483	10/24/00	SUZUKI, et al.			
	AE	6,026,262	2/15/00	KINOSHITA, et al.			
	AF	6,093,784	7/25/00	TAMURA, et al.			
	AG	5,747,204	5/5/98	ANZAI, et al.			
	AH	6,027,846	2/22/00	SHIMADA, et al.			
	AI	5,840,454	11/24/98	NAGAI, et al.			
	AJ	5,723,243	3/3/98	SASAKI, et al.			
	AK	5,942,363	8/24/99	TANAKA, et al.			
	AL	5,789,128	8/4/98	ADACHI, et al.			
	AM	5,846,680	12/8/98	ADACHI, et al.			
AN	6,030,736	2/29/00	IKEGAMI, et al.				
<b>FOREIGN PATENT DOCUMENTS</b>							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
<b>SKP</b> ↓	AO	4-295855	10/20/92	JAPAN w/English Abstract			
	AP	8-292585	11/5/96	JAPAN			
	AQ	9-281718	10/31/97	JAPAN w/English Abstract			
	AR	2000-66434	3/3/00	JAPAN w/English Abstract			
	AS	43-16198	7/8/68	JAPAN w/Partial English Translation			
	AT	44-834	1/16/69	JAPAN w/Partial English Translation			
	AU	49-10258	3/9/74	JAPAN w/Partial English Translation			
	AV	53-13344	11/31/78	JAPAN w/English Abstract			
	AW	04240656A	8/92	JAPAN			
	AX	2000352832A	12/00	JAPAN			
<b>OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)</b>							
<b>SKP</b>	AY	Derwent Abstracts, AN 1992-336267, JP 04-240656, August 27, 1992.					
	AZ						
Examiner <b><i>Senku Panta</i></b>					<input type="checkbox"/> Additional References sheet(s) attached Date Considered <b>3/4/06</b>		
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 240602US0DIV		SERIAL NO. <u>10/625,570</u> New Application	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Nozomu TAMOTO, et al.			
				FILING DATE Herewith		GROUP <u>1714</u>	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
SKP ↓ ✓	AAA	6,045,959	4/4/00	KATAYAMA, et al.			
	AAB	6,066,428	5/23/00	KATAYAMA, et al.			
	AAC	5,976,746	11/2/99	TAMAKA, et al.			
	AAD	6,468,706	10/22/02	MATSUDA, et al.			
	AAE	6,406,826	6/18/02	SUZUKI, et al.			
	AAF	6,322,940	11/27/01	NISHIGAKI, et al.			
	AAG	5,028,502	7/2/91	YUH, et al.			
	AAH	5,100,453	3/31/92	RICHARDS			
	AAI	6,249,304	6/19/01	SAWAYAMA, et al.			
	AAJ	5,834,145	11/10/98	YOSHINAGA, et al.			
	AAK	6,366,751	4/2/02	SHAKUTO, et al.			
	AAL	5,999,773	12/7/99	YASUTOMI, et al.			
	AAM	5,928,828	7/27/99	SUZUKI			
	AAN	5,910,561	8/8/99	ADACHI, et al.			
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION		
					YES	NO	
SKP ↓ ✓	AAO	55-157747	12/8/80	JAPAN w/English Abstract			
	AAP	57-30846	2/19/82	JAPAN w/English Abstract			
	AAQ	2-4275	1/9/90	JAPAN w/English Abstract			
	AAR	4-281461	10/7/92	JAPAN w/English Abstract			
	AAS	0 655 654	5/31/95	EUROPE			
	AAT						
AAU							
AAV							
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ						
Examiner <u>Santhi P. [Signature]</u>					<input type="checkbox"/> Additional References sheet(s) attached Date Considered <u>3/4/06</u>		
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				FILING DATE <b>Herewith</b>		GROUP <b>1714</b>	
<b>U.S. PATENT DOCUMENTS</b>							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
<b>SKIP</b>	AAAA	6,069,224	5/30/00	ADACHI, et al.			
	AAAB	6,191,249	2/20/01	TANAKA, et al.			
	AAAC	6,432,596	8/13/02	IKUNO, et al.			
	AAAD	6,319,878	11/20/01	INA, et al.			
	AAAE	5,702,855	12/30/97	IKEGAMI, et al.			
	AAAF	5,578,405	11/26/96	IKEGAMI, et al.			
	AAAG	5,339,138	8/16/94	MISHIMA, et al.			
	AAAH	5,496,671	3/5/96	TAMURA, et al.			
	AAAI	5,411,8276	5/2/95	TAMURA, et al.			
	AAAJ	4,942,104	7/17/90	KITAJIMA, et al.			
	AAAK	4,740,441	4/26/88	OTOMURA			
	AAAL	6,187,494	2/13/01	KAWAMURA, et al.			
	AAAM	6,187,492	2/13/01	RI, et al.			
	AAAN	6,210,848	4/3/01	NAGAI, et al.			
<b>FOREIGN PATENT DOCUMENTS</b>							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
	AAAO						
	AAAP						
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	AAAR						
	AAAS						
	AAAT						
	AAAU						
	AAAV						
<b>OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)</b>							
	AAAW						
	AAAX						
	AAAY						
	AAAZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner <i>Sushu Park</i>					Date Considered <b>3/4/06</b>		

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LIST OF REFERENCES CITED BY APPLICANT				APPLICANT <b>Nozomu TAMOTO, et al.</b>			
				FILING DATE <b>Herewith</b>		GROUP <b>1714</b>	
<b>U.S. PATENT DOCUMENTS</b>							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
<b>SKP</b>	AAB	6,326,112	12/4/01	TAMURA, et al.			
	ABB	6,444,387	9/3/02	RI, et al.			
	ACB	6,132,911	10/17/00	NIIMI			
	ADB	6,218,533	4/17/01	NIIMI			
	AEB	5,547,790	8/20/96	UMEDA, et al.			
	AFB	5,677,094	10/14/97	UMEDA, et al.			
	AGB	5,804,343	9/8/98	UMEDA, et al.			
	AHB	5,871,876	2/16/99	IKUNO, et al.			
	AIB	6,087,055	7/11/00	NIIMI			
	AJB	5,853,935	12/29/98	SUZUKI, et al.			
	AKB	6,118,964	9/00	KOJIMA, et al.			
	ALB	5,948,579	9/99	MASHIMO, et al.			
	AMB	4,663,259	5/87	FUJIMURA, et al.			
	ANB	4,766,048	8/88	HISAMUA, Masafumi			
	AOB	5,008,172	4/91	ROKUTANZONO, et al.			
	APB	6,300,027	10/01	CHAMBERS, et al.			
	AQB	6,492,081	12/02	MORIKAWA, et al.			
	ARB	2002/0048711	4/02	ITO, et al.			
	ASB	5,679,488	10/97	ITAMI, et al.			
	ATB	5,932,381	8/99	AKAO, et al.			
	AUB	2002/0011177	1/02	YAMAMORI, et al.			
	AVB	6,077,635	6/00	OKADO, et al.			
	AWB	6,243,552	6/01	MURATA, Jun			
	AXB	5,008,706	4/91	OHMORI, et al.			
<b>✓</b>	AYB	5,363,176	11/94	ISHIHARA, et al.			
<b>OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)</b>							
	AY						
	AZ						<input type="checkbox"/> Additional References sheet(s) attached
Examiner <b><i>Sandra Park</i></b>					Date Considered <b><i>3/4/06</i></b>		
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	Docket No.: 240602US0DIV	Serial No.: 10/625,570
LIST OF RELATED CASES CITED BY APPLICANT UNDER 37 CFR 1.56	Inventor: Nozomu TAMOTO, et al.	
	Filing Date: July 24, 2003	Group: 1756

**LIST OF RELATED CASES**

<u>Examiner Initial</u>	<u>Docket No.</u>	<u>Serial or Patent Number</u>	<u>Filing or Issue Date</u>	<u>Patent App. Publication No.</u>	<u>Inventor or Applicant</u>
SKP	240602US0DIV*	10/625,570	07/24/03	US2005/0100804 A1	TAMOTO, et al.
SKP	278309US0	11/245,135	10/07/05		NAGAI, et al.
SYP	280225US0	11/272,826	11/15/05		KAWASAKI, et al.

Examiner

*Samuel K. Park*

Date Considered

*March 9, 2006*

\*Present Application; listed for information  
NFO/hah